

Search Notes



Application/Control No.

10/519,424

Examiner

Sang Y. Paik

Applicant(s)/Patent under
Reexamination

CASERTA ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
392	386 — 396		
261	139 142		
	016.65	7/17/06	SP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST TEST RESEARCH	7/17/06	SP